

## 1024-Bit Serial (3V to 5V) Electrically Erasable PROM with 2V Read Capability

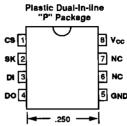
#### **FEATURES**

- State-of-the-Art Architecture
  - Nonvolatile data storage
  - 3V to 5V operation
  - Full TTL compatible inputs and outputs
  - Auto Increment for efficient data dump
- Hardware and Software Write Protection
  - Defaults to write-disabled state at power up
  - Software instructions for write-enable/disable
- Low Power Consumption
  - 1mA active (typical)
  - 1µA standby (typical)
- Low Voltage Read Operations
  - Reliable read operations down to 2.0 volts
- Advanced Low Voltage CMOS E<sup>2</sup>PROM Technology
- Versatile. Easy-to-Use Interface
  - Self-timed programming cycle
  - Automatic erase-before-write
  - Programming Status Indicator
  - Word and chip erasable
  - Stop SK anytime for power savings
- Durable and Reliable
  - 10-year data retention after 100K write cycles
  - Minimum of 100,000 write cycles per word
  - Unlimited read cycles
  - ESD protection

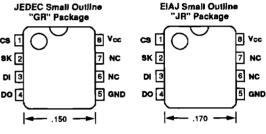
#### OVERVIEW

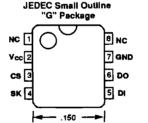
The XL93LC46-3 is a low cost 1024-bit, nonvolatile, serial E<sup>2</sup>PROM. It is fabricated using EXEL's advanced CMOS E<sup>2</sup>PROM technology. The XL93LC46-3 provides efficient nonvolatile read/write memory arranged as 64 registers of 16 bits each. Seven 9-bit instructions control the operation of the device, which include read, write, and mode enable functions. The data output pin (DO) indicates the status of the device during the self-timed nonvolatile programming cycle.

#### PIN CONFIGURATIONS











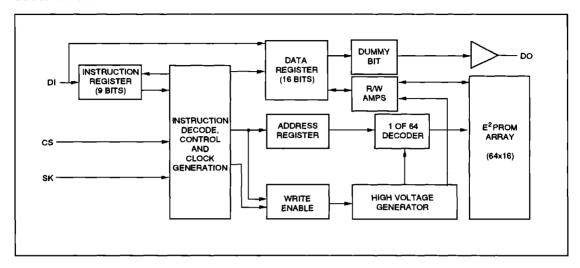
NOTE: The S.O. package types offer pinout options (GR & G) and (JR & J) respectively.

## **PIN NAMES**

CS Chip Select SK Serial Data Clock DI Serial Data Input DO Serial Data Output GND Ground Vcc Power Supply NC Not Connected



#### **BLOCK DIAGRAM**



The self-timed write cycle includes an automatic erase-before-write capability. To protect against inadvertent writes, the WRITE instruction is accepted only while the chip is in the write enabled state. Data is written in 16 bits per write instruction into the selected register. If Chip Select (CS) is brought HIGH after initiation of the write cycle, the Data Output (DO) pin will indicate the READY/BUSY status of the chip.

#### **APPLICATIONS**

The XL93LC46-3 is ideal for high volume applications requiring low power and low density storage. This device uses a low cost, space saving 8-pin package. Candidate applications include robotics, alarm devices, electronic locks, meters and instrumentation settings.

#### **ENDURANCE AND DATA RETENTION**

The XL93LC46-3 is designed for applications requiring up to 100,000 write cycles per bit. It provides 10 years of secure data retention without power after the execution of 100,000 write cycles for each location.

#### **DEVICE OPERATION**

The XL93LC46-3 is controlled by seven 9-bit instructions. Instructions are clocked in (serially) on the DI pin. Each instruction begins with a logical "1" (the start bit). This is followed by the opcode (2 bits), the address field (6 bits),

and data, if appropriate. The clock signal (SK) may be halted at any time and the XL93LC46-3 will remain in its last state. This allows full static flexibility and maximum power conservation.

## Read (READ)

The READ instruction is the only instruction that results in serial data on the DO pin. After the read instruction and address have been decoded, data is transferred from the selected memory register into a 16-bit serial shift register. (Please note that one logical "0" bit precedes the actual 16-bit output data string.) The output on DO changes during the low-to-high transitions of SK. (See Figure 3.)

#### Low Voltage Read

The XL93LC46-3 has been designed to ensure that data read operations are reliable in low voltage environments. The XL93LC46-3 is guaranteed to provide accurate data during read operations with  $V_{\rm CC}$  as low as 2.0V. (Note: When  $V_{\rm CC}$  falls as low as 2.0V, the maximum clock frequency is reduced to 250kHz.)

#### **Auto Increment Read Operations**

In the interest of memory transfer operation applications, the XL93LC46-3 has been designed to output a continuous stream of memory content in response to a single read operation instruction. To utilize this function, the system asserts a read instruction specifying a start location address. Once the 16 bits of the addressed word have been clocked out, the data in consecutively higher address locations is output. The address will wrap around continuously with CS HIGH until the Chip Select control pin is brought LOW. This allows for single instruction data dumps to be executed with a minimum of firmware overhead.

#### Write Enable (WEN)

The write enable (WEN) instruction must be executed before any device programming can be done. When Vcc is applied, this device powers up in the write disabled state. The device then remains in a write disabled state until a WEN instruction is executed. Thereafter the device remains enabled until a WDS instruction is executed or until Vcc is removed. (NOTE: Neither the WEN nor the WDS instruction has any effect on the READ instruction.) (See Figure 4.)

#### Write (WRITE)

The WRITE instruction includes 16 bits of data to be written into the specified register. After the last data bit has been applied to DI, and before the next rising edge of SK, CS must be brought LOW. The falling edge of CS initiates the self-timed programming cycle.

After a minimum wait of 250ns from the falling edge of CS (tcs), if CS is brought HIGH, DO will indicate the READY/BUSY status of the chip: logical "0" means programming is still in progress; logical "1" means the selected register has been written, and the part is ready for another instruction. (See Figure 5.) (NOTE: The combination of CS HIGH, DI HIGH and the rising edge of the SK clock, resets the READY/BUSY flag. Therefore, it is important if you want to access the READY/BUSY flag, not to reset through this combination of control signals.) Before a WRITE instruction can be executed, the device must be write enabled (see WEN).

#### Write All (WRALL)

The write all (WRALL) instruction programs all registers with the data pattern specified in the instruction.

As with the WRITE instruction, if CS is brought HIGH after a minimum wait of 250ns (tcs), the DO pin indicates the READY/BUSY status of the chip. (See Figure 6.)

#### Write Disable (WDS)

The write disable (WDS) instruction disables all programming capabilities. This protects the entire memory array against accidental modification of data until a WEN instruction is executed. (When Vcc is applied, this part powers up in the write disabled state.) To protect data, a WDS instruction should be executed upon completion of each programming operation. (NOTE: Neither the WEN nor the WDS instruction has any effect on the READ instruction.) (See Figure 7.)

## Erase Register

After the erase instruction is entered, CS must be brought LOW. The falling edge of CS initiates the self-timed internal programming cycle. Bringing CS HIGH after a minimum of tcs, will cause DO to indicate the READY/BUSY status of the chip: a logical "0" indicates programming is still in progress; a logical "1" indicates the erase cycle is complete and the part is ready for another instruction. (See Figure 8.)

#### Erase All (ERAL)

Full chip erase is provided for ease of programming. Erasing the entire chip involves setting all bits in the entire memory array to a logical "1." (See Figure 9.)

#### INSTRUCTION SET

Instruction	Start Blt	OP Code	Address	Input Data
READ	1	10	(A5-A0)	
WEN (Write Enable)	1	00	11XXXX	
WRITE	1	01	(A5-A0)	D15-D0
WRALL (Write All Registers)	1	00	01XXXX	D <sub>15</sub> -D <sub>0</sub>
WDS (Write Disable)	1	00	00XXXX	
ERASE	1	11	(A5-A0)	
ERAL (Erase All Registers)	1	00	10XXXX	



## **ABSOLUTE MAXIMUM RATINGS**

Temperature under bias: S93LC46	0°C to +70°C
E93LC46	40°C to +85°C
Storage Temperature	65°C to +125°C
Voltage with Respect to Ground	0.3 to +6.5V

NOTE: These are STRESS ratings only. Appropriate conditions for operating these devices are given elsewhere in this specification. Stresses beyond those listed here may permanently damage the part. Prolonged exposure to maximum ratings may affect device reliability.

## DC ELECTRICAL CHARACTERISTICS

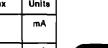
 $T_A = 0^{\circ}C$  to +70°C or -40°C to +85°C for E93LC46-3, Vcc = 3V ±10%

			S93LC46-3		E93LC46-3		
Symbol	Parameter	Conditions	Min	Max	Min	Max	Units
Icc	Operating Current CMOS Input Levels	CS = Vcc, SK = 250KHz		2		2	mA
Isa	Standby Current	CS = DI = SK =0V		2		2	μА
lu	Input Leakage	VIN = 0V to Vcc (CS, SK, DI)	-1	1	-1	1	μА
lLO	Output Leakage	Vout = 0V to Vcc, CS = 0V	-1	1	-1	1	μA
VIL	Input Low Voltage		-0.1	0.15 Vcc	-0 1	0.15 Vœ	V
Viн	Input High Voltage		0.8 Vcc	Vcc+0 2	0.8 Vcc	Vcc+0.2	V
Vol	Output Low Voltage	lou = 10µA CMOS		0.2		0.2	V
Voн	Output High Voltage	Ioн = -10µA CMOS	Vcc-0.2		Vcc-0.2		V

## **AC ELECTRICAL CHARACTERISTICS**

 $T_A = 0$ °C to +70°C or -40°C to +85°C for E93LC46-3,  $V_{CC} = 3V \pm 10\%$ 

			S93L	C46-3	E93LC46-3		
Symbol	Parameter	Conditions	Min	Max	Min	Мах	Units
fsĸ	SK Clock Frequency		0	250	0	250	KHz
tskH	SK High Time		1		1		μѕ
tskl	SK Low Time		1		1		μs
tcs	Minimum CS Low Time		1		1		μs
tcss	CS Setup Time	Relative to SK	200		200		ns
tois	DI Setup Time	Relative to SK	400		400		ns
tcsн	CS Hold Time	Relative to SK 1	0		0		ns
tDIH	DI Hold Time	Relative to SK	400		400		ns
LPD1	Output Delay to "1"	AC Test		2		2	μs
tPDo	Output Delay to "0"	AC Test		2		2	μs
tsv	CS to Status Valid	AC Test CL = 100pF		2		2	μs
tor	CS to DO in 3-state	CS = Low to DO = Hi-Z		400		400	ns
twp	Write Cycle Time	CS = Low to DO = Ready		20		25	ms





## DC ELECTRICAL CHARACTERISTICS

TA = 0°C to +70°C or -40°C to +85°C for E93LC46-3,  $V_{CC}$  = 5V  $\pm 10\%$ 

		rameter Conditions	S93LC46-3		E93LC46-3		
Symbol	Parameter		Min	Max	Min	Max	Unite
lcc1	Operating Current CMOS Input Levels	CS = Vcc, SK = 1MHz		2		2	mA
ICC2	Operating Current TTL Input Levels	CS = VIH, SK = 1MHz		5		5	mА
ise	Standby Current	CS = DI = SK =0V		2		2	μА
lu	Input Leakage	Vin = 0V to Vcc (CS, SK, DI)	-1	1	-1	1	μА
lLO	Output Leakage	Vout = 0V to Vcc, CS ≈ 0V	-1	1	-1	1	μА
VIL	input Low Voltage		-0.1	0.8	-0.1	0.8	٧
ViH	Input High Voltage		2	Vœ	2	Vec	٧
VOL1	Output Low Voltage	IoL = 2.1mA TTL		0 4		0.4	٧
Vон1	Output High Voltage	IOH = -400µA TTL	2.4		24		V
Vol2	Output Low Voltage	IoL = 10µA CMOS		0.2		0.2	V
Vo <sub>H2</sub>	Output High Voltage	loн = -10µA CMOS	Vcc-0.2		V∞-0.2		V

## **AC ELECTRICAL CHARACTERISTICS**

TA = 0°C to +70°C or -40°C to +85°C for E93LC46-3,  $V_{CC}$  = 5V ±10%

			S93LC46-3		E93LC46-3		
Symbol	Parameter	Conditions	Min	Mex	Min	Mex	Units
fsk	SK Clock Frequency		0	1	0	1	MHz
tskH	SK High Time		250		250		ns
tskL	SK Low Time		250		250		ns
tcs	Minimum CS Low Time		250		250		ns
tcss	CS Setup Time	Relative to SK	50		50		nŝ
tois	DI Setup Time	Relative to SK	100		100		ns
tcsH	CS Hold Time	Relative to SK	0		0		ns
toin	DI Hold Time	Relative to SK	100		100		ns
tPD1	Output Delay to "1"	AC Test		500		500	ns
tPD0	Output Delay to "0"	AC Test		500		500	пѕ
tsv	CS to Status Valid	AC Test CL = 100pF		500		500	ns
tor	CS to DO in 3-state	CS = Low to DO = Hi-Z		100		100	ns
twp	Write Cycle Time	CS = Low to DO = Ready		10		10	ms



## CAPACITANCE

TA = 25°C, f = 250KHz

Symbol	Parameter	arameter Max	
Соит	Output Capacitance	5	pF
Cin	Input Capacitance	5	pF

